

## **Notice of References Cited**

	Sec. 1		
Application/Control No.	Approx	Pätent Under	
09/903,365	Reexamination BJELLAND ET AL.		
Examiner	Art Unit		
Stephen M. D'Agosta	2683	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,640,105 B1	10-2003	Shin, Sang Rim	455/453
	В	US-6,671,367 B1	12-2003	Graf et al.	379/229
	С	US-6,466,585 B1	10-2002	Le, Khiem	370/465
	D	US-6,411,617 B1	06-2002	Kilkki et al.	370/353
	Е	US-6,490,451 B1	12-2002	Denman et al.	455/436
	F.	US-2002/0150091 A1	10-2002	Lopponen et al.	370/389
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO97-26739	07-1997	FI	Kari et al.	H04L 12/56
	0					
	Р					
	Q					
	R			,		
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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